Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/827,449	TANAKA ET AL.
Examiner	Art Unit
Mike Stahl	2874

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH I (INCLUDING SEAR		iY)
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